

<b>Notice of References Cited</b>	Application/Control No. 10/535,753		Applicant(s)/Patent Under Reexamination SLIKKERVEER ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,859,251	02-2005	Wang et al.	349/187
	B	US-			
	C	US-			
	D	US-			
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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